Motsuki Electric N-Channel 100-V (D-S) MOSFET

ME15N10/ME15N10-G

GENERAL DESCRIPTION

The ME15N10 is the N-Channel logic enhancement mode power field effect transistors, using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on state resistance. These devices are particularly suited for low voltage application such as cellular phone, notebook computer power management and other battery powered circuits, and low in-line power loss that are needed in a very small outline surface mount package.

FEATURES

R DS(ON) 100 m @VGS=10V

Super high density cell design for extremely low R

Exceptional on-resistance and maximum DC current

DS(ON)

capability

APPLICATIONS

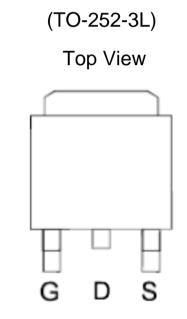
Power Management in Note book

DC/DC Converter

Load Switch

LCD Display inverter

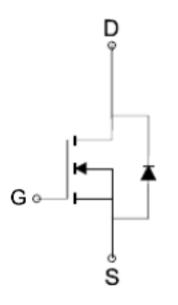
PIN CONFIGURATION



Ordering Information

: ME15N10 (Pb-free)

ME15N10-G (Green product-Halogen free)



N-Channel MOSFET

Absolute Maximum Ratings (TA=25 Unless Otherwise Noted)

Parameter Symbol			Rating	Unit	
Drain-Source Voltage		VDSS 100		V	
Gate-Source Voltage		VGSS ± 20		V	
Continuous Drain	T ^C =25	ID	14.7	A	
Current(Tj=150)	TC=70	I D	13.6		
Pulsed Drain Current		Ірм 59		А	
Maximum Power Dissipation	Tc=25	Do	34.7	· W	
	TC=70	PD	22.2		
Operating Junction Temperature		TJ	-55 to 150		
Thermal Resistance-Junction to Case *		R ^{JC} 3.6		/W	

^{*} The device mounted on 1in ² FR4 board with 2 oz copper

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Electrical Characteristics (TA = 25 Unless Otherwise Specified)

Symbol	Parameter	Limit	Min Typ		Max	Unit
STATIC		•		•		
BVpss Drain	-Source Breakdown Voltage	Vgs=0V, I D=250 μ A	100			V
VGS(th) Gate	Threshold Voltage	VDS=VGS, ID=250 μA	1		3 V	
Igss	Gate Leakage Current	⇒VDS=0V, VGS ± 20V			± 100	nA
IDSS	Zero Gate Voltage Drain Current	⇒VDS=80V, VGS 0V			1	μА
RDS(ON)	Drain-Source On-Resistance	Vgs=10V, I D= 8A		80	100	m
VsD	Diode Forward Voltage	IS=8A, V GS=0V		0.9	1.2	V
DYNAMIC		·				
Qg	Total Gate Charge	VDS=80V, VGS=10V, ID=10A		24		nC
Qg	Total Gate Charge			13		
Qgs Gate-So	urce Charge	VDS=80V, VGS=4.5V, ID=10A		4.6		
Qgd Gate-Di	ain Charge			7.6		
Ciss Input	Capacitance	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\		890		pF
Coss Output	Capacitance	VDS=15V, VGS=0V, f=1MHz		58		
Crss Revers	e Transfer Capacitance	I= IIVIMZ		23		
Rg Gate-Res	istance	VDS=0V, VGS=0V, f=1MHz		0.9		
td(on) Turn-C	n Delay Time			14		ns
tr Turn-On	Rise Time	VDS=50V, R L =5 ,		33		
td(off) Turn-C	ff Delay Time	VGEN =10V, R G=1		39		
tf Turn-Off	Fall Time			5		

Notes: a. Pulse test: pulse width

300us, duty cycle

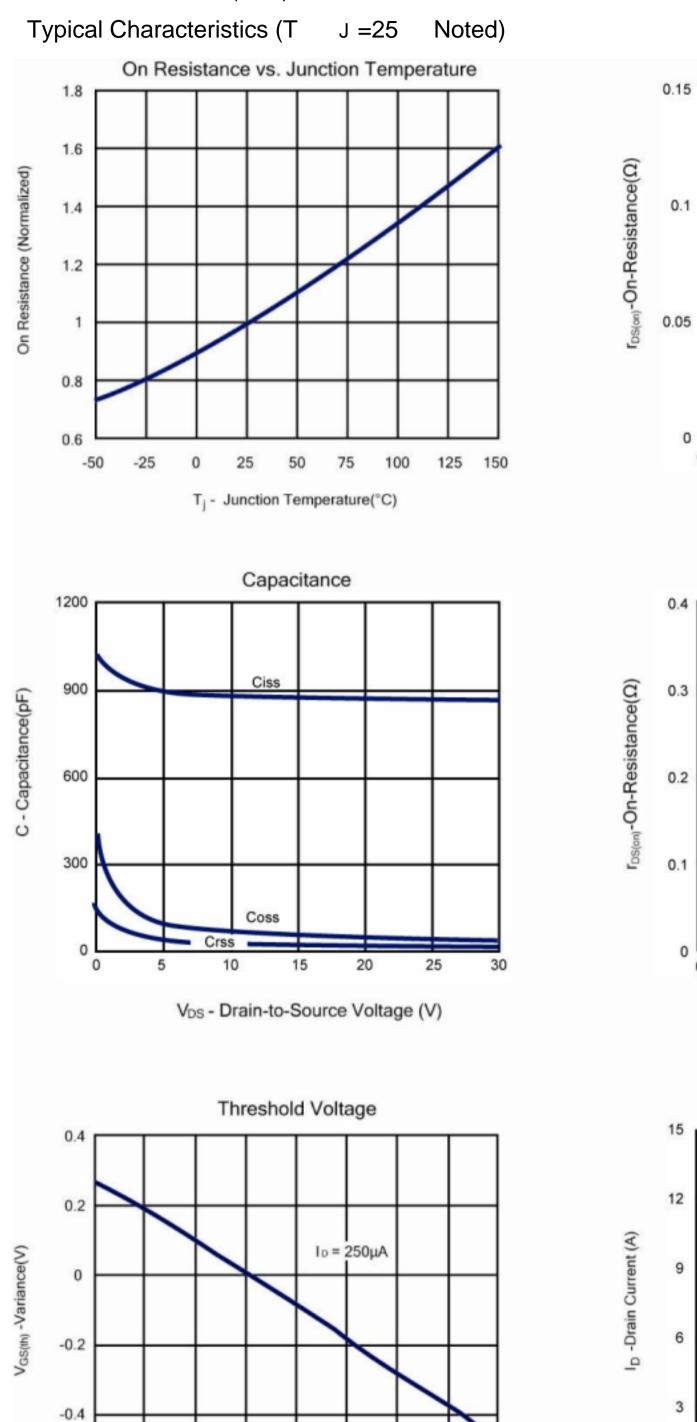
2%, Guaranteed by design, not subject to production testing.

b. Matsuki reserves the right to improve product design, functions and reliability without notice.

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-0.6

-50

-25

0

25

50

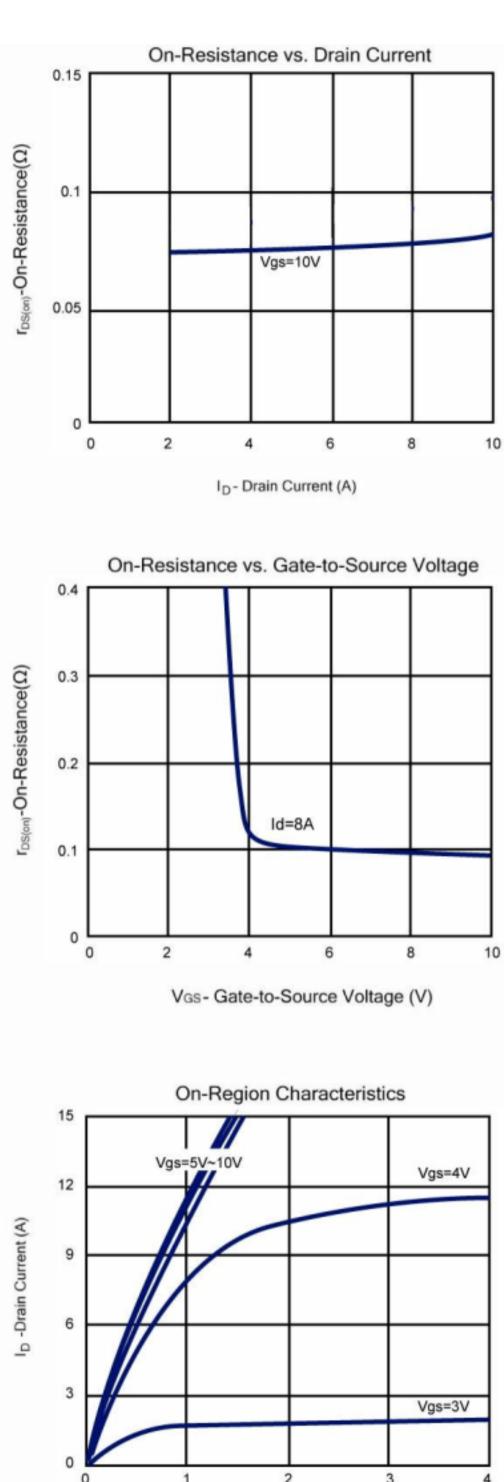
T_J - Temperature(°C)

75

100

125

150



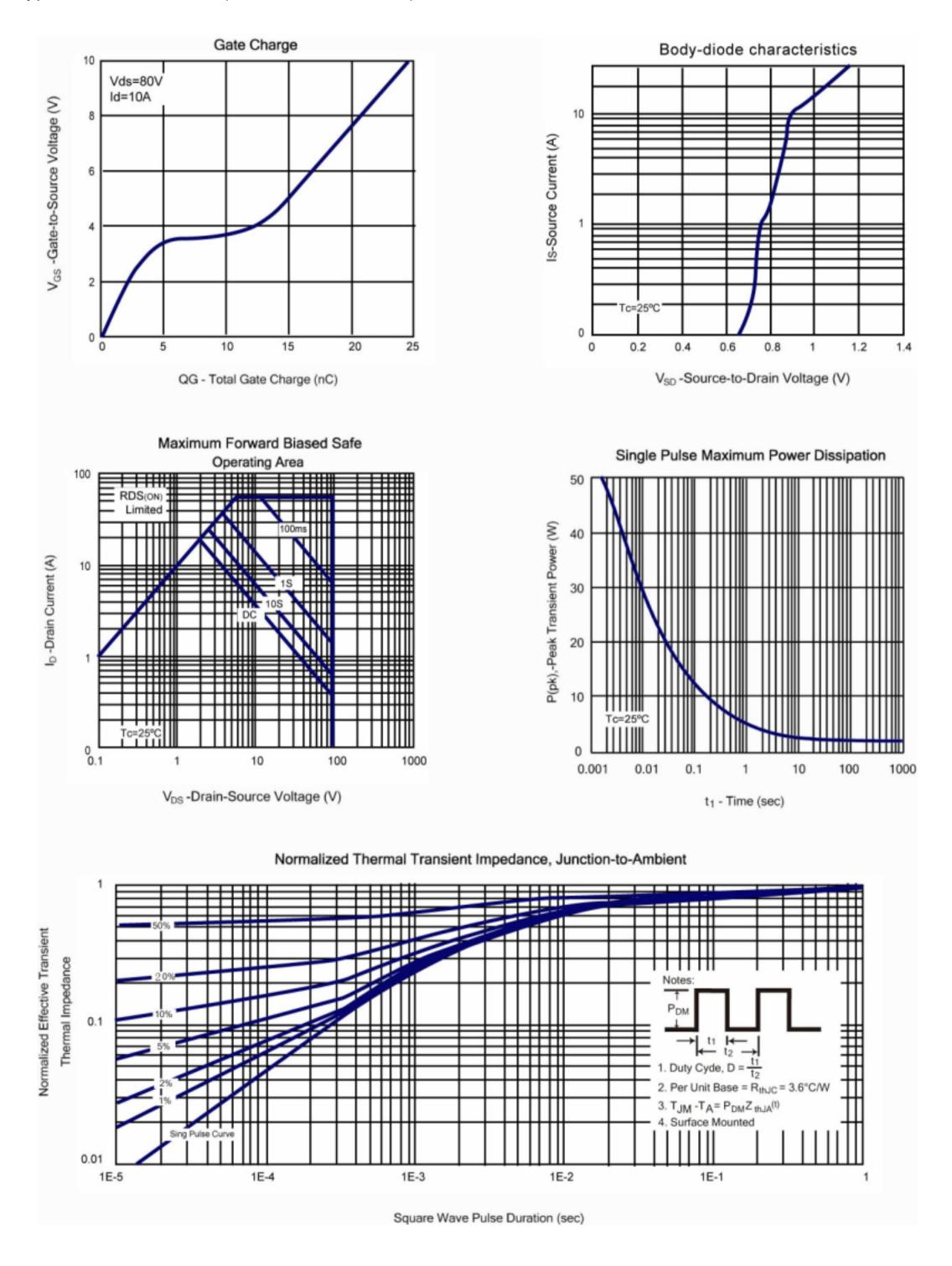
V_{DS} - Drain-to-Source Voltage (V)

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Typical Characteristics (T J = 25 Noted)



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